

CH-410

Physical and chemical analyses of materials

Roussel Christophe

| Cursus | Sem. | Type |
|------------|----------|------|
| Chimiste | MA2, MA4 | Opt. |
| Ing.-chim. | MA2, MA4 | Opt. |

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| Language of teaching | English |
| Credits | 3 |
| Session | Summer |
| Semester | Spring |
| Exam | Written |
| Workload | 90h |
| Weeks | 14 |
| Hours | 2 weekly |
| Courses | 2 weekly |
| Number of positions | |

Summary

The course relates on the use of electromagnetic (X-Ray) and corpuscular (electrons) radiations for physical and chemical analysis of solid materials.

Content**1. Fundamentals of beam interactions with materials**

- Matter excitation: elastic, inelastic interactions of X-ray photons and electrons with matter
- Matter relaxation: spectroscopy and spectrometry

2. Microscopy

- Electron microscopy: Scanning and Transmission Electron Microscopies
- Scanning probe microscopy: Scanning Tunelling and Atomic Force Microscopies

3. Chemical analysis

- Bulk analysis of materials: X-ray emission and X-ray Fluorescence Spectrometries
- Surface analysis of materials: X-Ray Photoelectron and Auger Electron Spectrometries

4. Chemiometry

- Basics of statistics
- Analyses of variance ANOVA

Assessment methods

written exam